

Search Notes

Application/Control No.

10/566,986

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

TERADA, TOMOYASU

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
174	72a	9/2/2006	LEE
↓	68.3	↓	↓
↓	73.1	↓	↓
174	as above	2/20/2007	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
174	as above	9/2/2006	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See text search attached	9/2/2006	LEE